HY5118164B,HY5116164B 1Mx16, Extended Data Out mode

DESCRIPTION

This family is a 16M bit dynamic RAM organized 1,048,576 x 16-bit configuration with Extended Data Out mode CMOS DRAMs. Extended data out mode is a kind of page mode which is useful for the read operation. The circuit and process design allow this device to achieve high performance and low power dissipation. Optional features are access time(60, 70 or 80ns) and refresh cycle(1K ref. or 4K ref.) and power consumption (Normal or Low power with self refresh). Hyundai's advanced circuit design and process technology allow this device to achieve high bandwidth, low power consumption and high reliability.

FEATURES

- Extended data out operation
- · Read-modify-write Capability
- TTL compatible inputs and outputs
- /CAS-before-/RAS, /RAS-only, Hidden and Self refresh capability
- · Max. Active power dissipation

Speed	1K refresh	4K refresh
60	880m W	550m W
70	825m W	495m W
80	770m W	440m W

• Refresh cycle

Part number	Refresh	Normal	SL-part
HY5118164C	1K	16ms	256ms
HY5116164C	4K	64ms	2561118

- JEDEC standard pinout
- 42-pin Plastic SOJ (400mil)
 44/50-pin plastic TSOP-II (400mil)
- Single power supply of 5V ± 10%
- · Early write or output enable controlled write
- Fast access time and cycle time

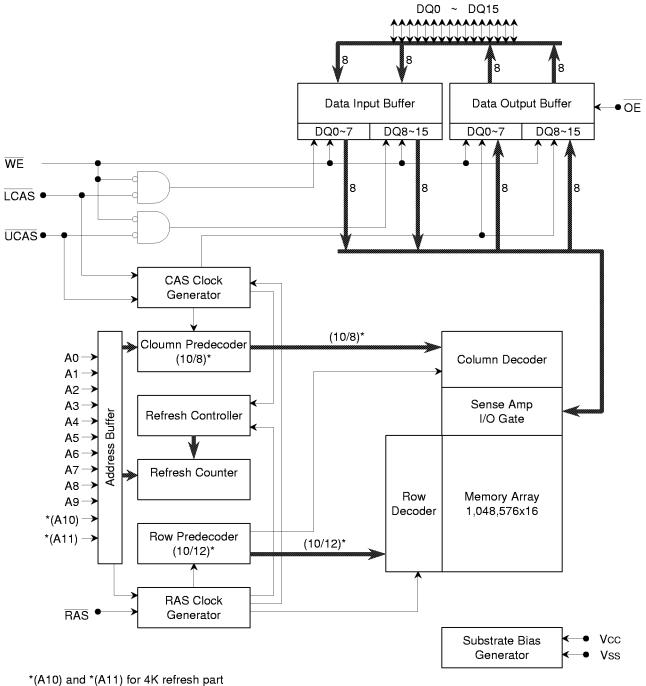
Speed	tRAC	tCAC	tHPC
60	60ns	15ns	25ns
70	70ns	20ns	30ns
80	80ns	20ns	35ns

ORDERING INFORMATION

Part Name	Refresh	Power	Package
HY5118164BJC	1K		42Pin SOJ
HY5118164BSLJC	1K	SL-part	42Pin SOJ
HY5118164BTC	1K		44/50Pin TSOP-II
HY5118164BSLTC	1K	SL-part	44/50Pin TSOP-II
HY5116164BJC	4K		42Pin SOJ
HY5116164BSLJC	4K	SL-part	42Pin SOJ
HY5116164BTC	4K		44/50Pin TSOP-II
HY5116164BSLTC	4K	SL-part	44/50Pin TSOP-II

^{*}SL: Low power with self refresh

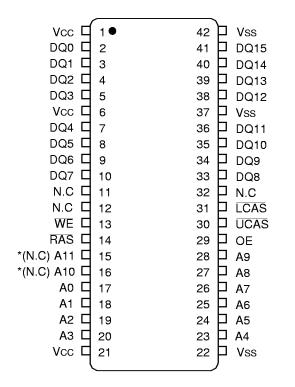
FUNCTIONAL BLOCK DIAGRAM

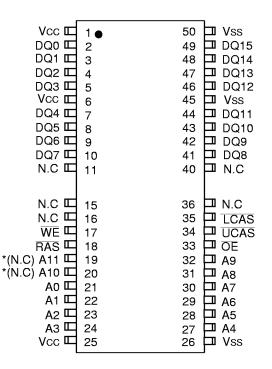


*(A10) and *(A11) for 4K refresh part (1K Refresh / 4K Refresh)*



PIN CONFIGURATION (Marking Side)





42Pin Plastic SOJ (400mil)

44/50Pin Plastic TSOP- II (400mil)

*(N.C): For 1K refresh product

PIN DESCRIPTION

Pin Name	Parameter
/RAS	Row Address Strobe
/CAS	Column Address Strobe
/WE	Write Enable
/OE	Output Enable
A0~A11	Address Input (4K Refresh Product)
A0~A9	Address Input (1K Refresh Product)
DQ0~DQ15	Data In/Out
Vcc	Power (5V)
Vss	Ground
NC	No Connection



ABSOLUTE MAXIMUM RATING

Symbol	Parameter	Rating	Unit
Та	Ambient Temperature	0 to 70	°C
Tstg	Storage Temperature	-55 to 150	°C
VIN, VOUT	Voltage on Any Pin relative to Vss	-1.0 to 7.0	
Vcc	Voltage on Vcc relative to Vss	-1.0 to 7.0	٧
los	Short Circuit Output Current	50	mA
PD	Power Dissipation	1	w
TSOLDER	Soldering Temperature • Time	260 • 10	°C • sec

Note: Operation at or above Absolute Maximum Ratings can adversely affect device reliability

RECOMMENDED DC OPERATING CONDITIONS

 $(TA = 0^{\circ}C \text{ to } 70^{\circ}C)$

Symbol	Parameter	Min	Тур	Max	UNIT
Vcc	Power Supply Voltage	4.5	5.0	5.5	V
VIH	Input High Voltage	2.4	-	Vcc+1.0	V
VIL	Input Low Voltage	-1.0	-	0.8	V

Note: All voltages are referenced to Vss.

DC OPERATING CHARACTERISTIC

Symbol	Parameter	rameter Test condition		Max	Unit	
lLi	Input Leakage Current (Any input)	Vss ≤ VIN ≤ Vcc + 1.0 All other pins not under test = Vss	-10	10	μА	
llo	Output Leakage Current (Any input)	Vss ≤ Vouт ≤ Vcc /RAS & /CAS at ViH	-10	10	μА	
Vol	Output Low Voltage	IOL = 4.2mA	-	0.4	V	
Vон	Output High Voltage	IOH = -5.0mA	2.4	-	V	



DC CHARACTERISTICS

(TA = 0°C to 70°C , Vcc = 5V \pm 10%, Vss = 0V, unless otherwise noted.)

Symbol	Parameter	Test condition	Speed	Max. C	Unit		
				1K Ref	4K Ref		
lcc1	Operating Current	/RAS, /CAS Cycling tRC = tRC(min.)	60 70 80	160 150 140	100 90 80	mA	
lcc2	TTL Standby Current	/RAS, /CAS ≥ VIH Other inputs ≥ Vss	SL-part	2 1	2 1	mA	
ICC3	/RAS-only Refresh Current	/RAS Cycling,/CAS = VIH tRC = tRC(min.)	60 70 80	160 150 140	100 90 80	mA	
ICC4	EDO mode Current	/CAS Cycling, /RAS = VIL tHPC = tHPC(min.)	60 70 80	140 120 100	90 80 70	mA	
ICC5	CMOS Standby Current	/RAS = /CAS ≥ Vcc - 0.2V	SL-part	1 300	1 300	mA μA	
ICC6	/CAS-before-/RAS Refresh Current	/RAS & /CAS = 0.2V tRC = tRC(min.)	60 70 80	160 150 140	100 90 80	mA	
ICC7	Battery Back-up Current (SL-part)	tRC=250µs (1K Ref), 62.5µs (4K Ref) /CAS = CBR cycling 0.2V /OE & /WE = Vcc - 0.2V	tRAS ≤ 300ns	350	350		
		Address = Vcc-0.2V or 0.2V DQ0~DQ15 = Vcc-0.2, 0.2V or Open	tRAS ≤ 1µs	450	450	μΑ	
lcc8	Self Refresh Current (SL-part)	/RAS & /CAS = 0.2V Other pins are same as ICC7		350	350	μΑ	

Note

- 1. lcc1, lcc3, lcc4 and lcc6 depend on output loading and cycle rates(tRC and tHPC).
- 2. Specified values are obtained with output unloaded.
- 3. Icc is specified as an average current. In Icc1, Icc3, Icc6, address can be changed only once while /RAS=VIL. In Icc4, address can be changed maximum once while /CAS=VIH within one EDO mode cycle time tHPC.



AC CHARACTERISTICS

(Ta = 0 °C to 70 °C, Vcc = 5V \pm 10% , Vss = 0V, unless otherwise noted.)

Over to the	Parameter	60	Ins	70	ins	80	ns		Note
Symbol		Min	Max	Min	Max	Min	Max	Unit	
trc	Random read or write cycle time	105	-	125	-	145	-	ns	
trwc	Read-modify-write cycle time	142	-	167	-	187	-	ns	
tHPC	EDO mode cycle time	25	-	30	-	35	-	ns	2
tHPRWC	EDO mode read-modify-write cycle time	73	-	85	-	100	-	ns	2
trac	Access time from /RAS	-	60	-	70	-	80	ns	5,6,7
tCAC	Access time from /CAS	-	15	-	20	-	20	ns	5,6
taa	Access time from column address	-	30	-	35	-	40	ns	5
tCPA	Access time from column precharge	-	35	-	35	-	40	ns	5
tCLZ	/CAS to output low impedance	0	-	0	-	0	-	ns	5
tCEZ	Output buffer turn-off delay from /CAS	3	15	3	15	3	15	ns	8,12
tт	Transition time(rise and fall)	2	50	2	50	2	50	ns	3
trp	/RAS precharge time	40	-	50	-	60	-	ns	
tras	/RAS pulse width	60	10K	70	10K	80	10K	ns	
trasp	/RAS pulse width(EDO mode)	60	100K	70	100K	80	100K	ns	
trsh	/RAS hold time	13	-	15	-	20	-	ns	
tcsн	/CAS hold time	40	-	50	-	60	-	ns	
tcas	/CAS pulse width	13	10K	15	10K	20	10K	ns	
tRCD	/RAS to /CAS delay time	20	45	20	50	20	60	ns	6
trad	/RAS to column address delay time	15	30	15	35	15	40	ns	7
tCRP	/CAS to /RAS precharge time	5	-	5	-	5	-	ns	11
tCP	/CAS precharge time	7	-	10	-	10	-	ns	16
tasr	Row address set-up time	0	-	0	-	0	-	ns	
trah	Row address hold time	10	-	10	-	10	-	ns	
tasc	Column address set-up time	0	-	0	-	0	-	ns	
tCAH	Column address hold time	10	-	15	-	15	-	ns	
tral	Column address to /RAS lead time	30	-	35	-	40	-	ns	
trcs	Read command set-up time	0	-	0	-	0	-	ns	
trch	Read command hold time referenced to /CAS	0	-	0	-	0	-	ns	9
trrh	Read command hold time referenced to /RAS	0	-	0	-	0	-	ns	9
twch	Write command hold time	10	-	15	-	15	-	ns	
twp	Write command pulse width	10	-	10	-	10	-	ns	
trwL	Write command to /RAS lead time	15	-	15	-	15	-	ns	
tcwL	Write command to /CAS lead time	13	_	15	_	20	_	ns	16



AC CHARACTERISTICS

Continued

Cumbal	Darameter		ns	70ns		80ns		11	Nata
Symbol	Parameter	Min	Max	Min	Max	Min	Max	Unit	Note
tos	Data-in set-up time	0	-	0	-	0	-	ns	10
tDH	Data-in hold time	10	-	15	-	15	-	ns	10
	Refresh period(1024 cycles)	-	16	-	16	-	16	ms	
tref	Refresh period(4096 cycles)	-	64	-	64	-	64	ms	
	Refresh period(SL-part)	-	256	-	256	-	256	ms	
twcs	Write command set-up time	0	-	0	-	0	-	ns	11
tcwD	/CAS to /WE delay time	37	-	45	-	45	-	ns	11,15
trwD	/RAS to /WE delay time	80	-	95	-	105	-	ns	11
tawd	Column address to /WE delay time	50	-	60	-	65	-	ns	11
tcsr	/CAS set-up time(CBR cycle)	5	-	5	-	5	-	ns	17
tchr	/CAS hold time(CBR cycle)	10	-	10	-	10	-	ns	18
trpc	/RAS to /CAS precharge time	5	-	5	-	5	-	ns	
tCPT	/CAS precharge time(CBR counter test)	30	-	35	-	40	-	ns	14
troh	/RAS hold time referenced to /OE	10	-	10	-	10	-	ns	
toea	/OE access time	-	15	-	20	-	20	ns	
tOED	/OE to data delay time	15	-	20	-	20	-	ns	
toez	Output buffer turn-off delay time from /OE	3	15	3	15	3	15	ns	8
toeh	/OE command hold time	15	-	20	-	20	-	ns	
tCPWD	/WE delay time from /CAS precharge	55	-	65	-	75	-	ns	11
trhcp	/RAS hold time from /CAS precharge	40	-	40	-	50	-	ns	
twrp	/WE to /RAS precharge time(CBR cycle)	10	-	10	-	10	-	ns	
twrH	/WE to /RAS hold time(CBR cycle)	10	-	10	-	10	-	ns	
trass	/RAS pulse width(self refresh)	100K	-	100K	-	100K	-	ns	
trps	/RAS Precharge Time (Self refresh)	110	-	130	-	150	-	ns	
tchs	/CAS Hold Time (Self refresh)	-50	-	-50	-	-50	-	ns	
tDOH	Output Data Hold Time	5	-	5	-	5	-	ns	
tREZ	Output Buffer Turn Off Delay Time from /RAS	3	15	3	15	3	15	ns	
twez	Output Buffer Turn Off Delay Time from /WE	3	15	3	15	3	15	ns	
tWED	/WE to Data Delay Time	15	-	15	-	15	-	ns	
tOEP	/OE Precharge Time	5	-	5	-	5	-	ns	
twpe	/WE Pulse Width (EDO cycle)	5	-	5	-	5	-	ns	
toch	/OE to /CAS Hold Time	5	-	5	-	5	-	ns	
tcho	/CAS Hold Time to /OE	5	-	5	-	5	-	ns	

NOTE

- An initial pause of 200 μs is required after power-up followed by 8 /RAS only refresh cycles before proper device operation is achieved. In case of using internal refresh counter, a minimum of 8 CBR refresh cycles instead of 8 /RAS-only refresh cycles are required.
- 2 tasc ≥ tcp(min), assume tT=2ns.
- 3. VIH(min.) and VIL(max.) are reference levels for measuring timing of input signals. Transition times are measured between VIH(min.) and VIL(max.)
- 4. The minimum specifications are used only to indicate cycle time at which proper operation over the full temperature range (TA=0 to 70; C) is assured.
- 5. Measured at VOH=2.0V and VOL=0.8V with a load equivalent to 2TTL loads and 100pF.
- 6. Operation within the tRCD(max.) limit ensures that tRAC(max.) can be met. tRCD(max.) is specified as a reference point only.

 If tRCD is greater than the specified tRCD(max.) limit, then access time is controlled by tCAC.
- 7. Operation within the tRAD(max.) limit ensures that tRAC(max.) can be met. tRAD(max.) is specified as a reference point only.

 If tRAD is greater than the specified tRAD(max.) limit, then access time is controlled by tAA.
- 8. tWEZ, tREZ, tCEZ and tOEZ define the time at which the output achieves the open circuit condition and is not referenced to output voltage levels.
- 9. Either tRCH or tRRH must be satisfied for a read cycle.
- 10. These parameters are referenced to /LCAS or /UCAS leading edge in early write cycles and to /WE leading edge in read-modify-write cycles.
- 11.twcs, tRWD, tCWD, tAWD and tCPWD are not restrictive operating parameters. They are included in the data sheet as electrical characteristics only. If twcs ≥ twcs(min.), the cycle is an early write cycle and data out pin will remain open circuit (high impedance) through the entire cycle. If tRWD ≥ tRWD(min.), tCWD ≥ tCWD(min.), tAWD ≥ tAWD(min), and tCPWD ≥ tCPWD(min.), the cycle is a read-modify-write cycle and data out will contain data read from the selected cell. If neither of the above sets of conditions is satisfied, the condition of the data out (at access time) is indeterminate.
- 12.If /RAS goes to high before /CAS high going, the open circuit condition of the output is achieved by /CAS high going. If /CAS goes to high before /RAS high going, the open circuit condition of the output is achieved by /RAS high going.
- 13.tASC,tCAH are referenced to the earlier /CAS falling edge.
- 14.tcP and tcPT are measured when both /LCAS and /UCAS are high state.
- 15.tcwD is referenced to the later /CAS falling edge at word read-modifiy-write cycle.
- 16.tcwL must be satisfied by both /LCAS and /UCAS for 16-bit access cycles.
- 17.tcsr is referenced to the earlier /CAS falling before /RAS transition low.
- 18.tchr is referenced to the later /CAS rising high after /RAS transition low.
- 19.tds, tdh is independently specified for lower byte DQ(0-7), upper byte DQ(8-15).

CAPACITANCE

(TA = 25°C, VCC = 5V \pm 10%, Vss = 0V and f=1MHz, unless otherwise noted.)

Symbol	Parameter	Тур.	Max	Unit
CIN1	Input Capacitance (A0~A11)	-	5	pF
CIN2	Input Capacitance (/RAS, /LCAS,/UCAS, /WE, /OE)	-	7	pF
CDQ	Data Input / Output Capacitance (DQ0~DQ15)	-	7	pF